

Notice of References Cited	Application/Control No. 10/715,326		Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Thanh T. Nguyen		Art Unit 2813	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-2003/0003770	01-2003	Morita et al.	438/778
X	B	US-2002/0142218	10-2002	Reitz et al.	429/219
X	C	US-2003/0013280	01-2003	Yamanaka, Hideo	438/487
X	D	US-2003/0218189	11-2003	Christiansen et al.	257/200
X	E	US-2001/0037860	11-2001	Morita, Kiyoyuki	156/345
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.